

Search Notes

Application/Control No.

10/625,794

Examiner

Quan Tra

Applicant(s)/Patent under
Reexamination

SHIRATO, KEIJI

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
limited search 327/530, 536, 589	8/4/2006	QT